

# Outline

- 1) Testing with nuisance parameters
- 2) UMPU multivariate tests
- 3) Conditioning on null sufficient stat

# Nuisance Parameters

Common setup: Extra unknown parameters  
which are not of direct interest

$$\mathcal{P} = \{ P_{\theta, \lambda} : (\theta, \lambda) \in \Omega \}, H_0: \theta \in \Theta_0 \text{ vs } H_1: \theta \in \Theta_1$$

$\theta$  parameter of interest

$\lambda$  nuisance parameter

Issue:  $\lambda$  unknown but might affect  
type I error or power of a given test

Ex  $X_1, \dots, X_n \stackrel{iid}{\sim} N(\mu, \sigma^2)$       $Y_1, \dots, Y_m \stackrel{iid}{\sim} N(\nu, \sigma^2)$

$\mu, \nu, \sigma^2$  unknown

$$H_0: \mu = \nu \text{ vs } H_1: \mu \neq \nu$$

$$\theta = \mu - \nu \quad \lambda = (\mu + \nu, \sigma^2) \quad \text{or } (\mu, \sigma^2)$$

Ex  $X_1 \sim \text{Binom}(n_1, \pi_1)$       $X_2 \sim \text{Binom}(n_2, \pi_2)$

$n_1, n_2$  known  $\Rightarrow$  not nuisance parameters

$$H_0: \pi_1 \leq \pi_2 \text{ vs } H_1: \pi_1 > \pi_2$$

# Multiparameter Exp. Families

Assume  $X \sim p_{\theta, \lambda}(x) = e^{\theta' T(x) + \lambda' u(x) - A(\theta, \lambda)} h(x)$

$\theta \in \mathbb{R}^s$ ,  $\lambda \in \mathbb{R}^r$ , both unknown.

How to test  $H_0: \theta \in \Theta_0$  vs  $H_1: \theta \in \Theta_1$ ?

Idea: Condition on  $U(X)$  to eliminate dep. on  $\lambda$

1) Sufficiency reduction:

$$(T(X), U(X)) \sim q_{\theta, \lambda}(t, u)$$

$$= e^{\theta' t + \lambda' u - A(\theta, \lambda)} g(t, u)$$

(density wrt e.g. Lebesgue on  $\mathbb{R}^{\text{str}}$ )

2) Condition on  $U(X)$ :

$$q_{\theta}(t | u) = \frac{q_{\theta, \lambda}(t, u)}{\int q_{\theta, \lambda}(z, u) dz}$$

$$= \frac{e^{\theta' t + \cancel{\lambda' u} - \cancel{A(\theta, \lambda)}} g(t, u)}{\int e^{\theta' z + \cancel{\lambda' u} - \cancel{A(\theta, \lambda)}} g(z, u) dz}$$

$$= e^{\theta' t - B_u(\theta)} g(t, u)$$

3) Conditional test:

Test  $H_0: \theta \in \Theta_0$  vs.  $H_1: \theta \in \Theta_1$  in

$s$ -parameter model  $\mathcal{Q}_n = \{q_\theta(t|w) : \theta \in \Theta\}$

Note if  $s=1$ , this family has MLR in  $T$

Even if  $s > 1$ , we still have gotten rid of  $\lambda$

Theorem (Informal)

Theorem Let  $\mathcal{P}$  be full rank exp. fam. with densities

$$p_{\theta, \lambda}(x) = e^{\theta^T(x) + \lambda^T U(x) - A(\theta, \lambda)} h(x)$$

$\theta \in \mathbb{R}$ ,  $\lambda \in \mathbb{R}^r$ ,  $(\theta, \lambda) \in \Omega$  open,  $\theta_0$  possible

a) To test  $H_0: \theta \leq \theta_0$  vs.  $H_1: \theta > \theta_0$ , there is a UMPU test  $\phi^*(x) = \gamma(T(x); U(x))$  where

$$\gamma(t; u) = \begin{cases} 1 & t > c(u) \\ \gamma(u) & t = c(u) \\ 0 & t < c(u) \end{cases}$$

with  $c(u)$ ,  $\gamma(u)$  chosen to make

$$\mathbb{E}_{\theta_0} [\phi^*(x) | U(x) = u] = \alpha$$

b) To test  $H_0: \theta = \theta_0$  vs.  $H_1: \theta \neq \theta_0$  there is a UMPU test  $\phi^*(x) = \gamma(T(x); U(x))$  where

$$\gamma(t; u) = \begin{cases} 1 & t < c_1(u) \text{ or } t > c_2(u) \\ \gamma_i(u) & t = c_i(u) \\ 0 & t \in (c_1(u), c_2(u)) \end{cases}$$

with  $c_i(u)$ ,  $\gamma_i(u)$  chosen to make

$$\mathbb{E}_{\theta_0} [\phi^*(x) | U(x) = u] = \alpha$$

$$\mathbb{E}_{\theta_0} [T(x)(\phi^*(x) - \alpha) | U(x) = u] = 0$$

[Note  $\lambda$  has disappeared from the problem.]

$$\underline{\text{Ex}}: X_i \stackrel{\text{ind.}}{\sim} \text{Pois}(\mu_i) \quad i=1, 2$$

$$H_0: \mu_1 \leq \mu_2 \quad \text{vs.} \quad H_1: \mu_1 > \mu_2$$

$$p_{\mu}(x) = \prod_{i=1}^2 \frac{\mu_i^{x_i} e^{-\mu_i}}{x_i!}$$

$$= e^{X_1 \eta_1 + X_2 \eta_2 - (e^{\eta_1} + e^{\eta_2})} \frac{1}{x_1! x_2!}$$

$$\text{(Where } \eta_i = \log \mu_i \text{ . } H_0: \eta_1 \leq \eta_2 \quad H_1: \eta_1 > \eta_2 \text{)}$$

$$= e^{X_1 \underbrace{(\eta_1 - \eta_2)}_{\theta} + (X_1 + X_2) \eta_2 - A(\eta)} \frac{1}{x_1! x_2!}$$

$$H_0: \theta \leq 0 \quad \text{vs.} \quad H_1: \theta > 0$$

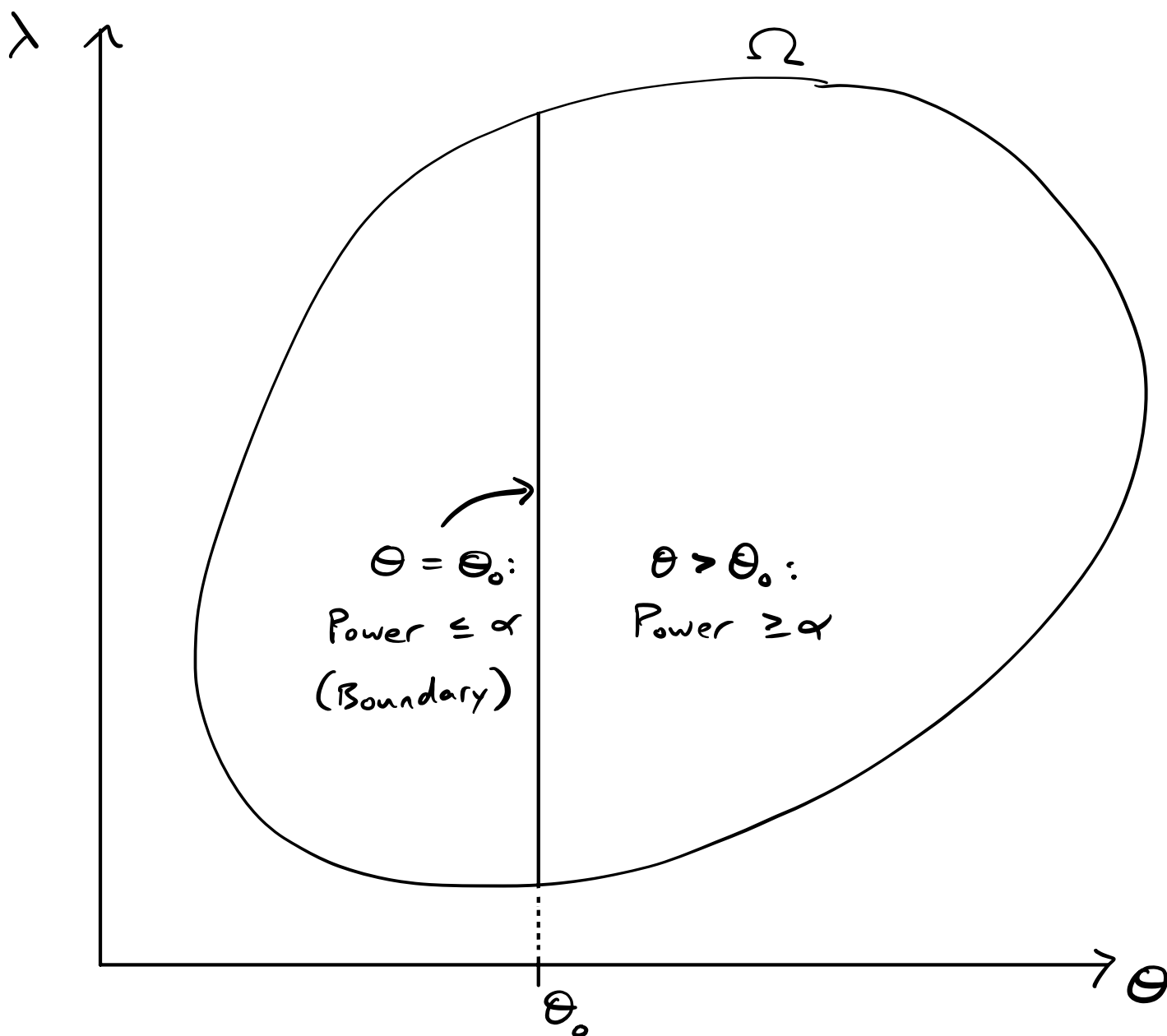
Reject for conditionally large values of  $X_1$ , given  $X_1 + X_2 = u$

$$\begin{aligned} P_{\theta}(X_1 = x_1 | U = u) &= e^{x_1 \theta + \cancel{u\theta} - \cancel{A(\cdot)}} \cdot \frac{1}{x_1! (u-x_1)!} \bigg/ \sum_{x_1=0}^u \frac{1}{x_1! (u-x_1)!} \\ &\propto_{x_1} e^{x_1 \theta} \cdot \frac{u!}{x_1! (u-x_1)!} \\ &= \text{Binom}\left(u, \frac{e^{\theta}}{1+e^{\theta}}\right) \quad e^{\theta} = \mu_1/\mu_2 \end{aligned}$$

$$= \text{Binom}\left(u, \frac{\mu_1}{\mu_1 + \mu_2}\right)$$

So in the end we do a Binomial test.

# Proof Sketch



- 1) Any unbiased test has  $\beta(\theta_0, \lambda) = \alpha \quad \forall \lambda$   
(continuity)
- 2) Power  $\equiv \alpha$  on boundary  $\Rightarrow \mathbb{E}_{\theta_0}[\phi | U] \stackrel{q.s.}{=} \alpha$   
( $U(x)$  complete sufficient on boundary submodel)
- 3)  $\phi^*$  optimal among all tests with conditional level  $\alpha$   
(by reduction to univariate model)

Proof Assume  $\phi$  any unbiased test

Step 1:  $\mathbb{E}_{\theta, \lambda} |\phi(x)| \leq 1 < \infty \quad \forall (\theta, \lambda) \in \Omega$

(Keener Thm 2.4)

$\Rightarrow \mathbb{E}_{\theta, \lambda} \phi(x)$  infinitely diff. on  $\Omega$ , can diff. under  $\int$

$\phi$  unbiased  $\Rightarrow \mathbb{E}_{\theta, \lambda} [\phi(x)] = \alpha \quad \forall (\theta, \lambda) \in \Omega$

Step 2: Boundary submodel:  $\mathcal{P}_{\theta_0} = \{P_{\theta_0, \lambda} : (\theta_0, \lambda) \in \Omega\}$

$$P_{\theta_0, \lambda}(x) = e^{\lambda' u(x) - A(\theta_0, \lambda)} \cdot \frac{e^{\theta_0' T(x)}}{h(x)}$$

$\mathcal{P}_{\theta_0}$  is full-rank,  $s$ -param exp. fam,  $u(x)$  comp. suff.

Let  $f(u) = \mathbb{E}_{\theta_0} [\phi(x) | u(x) = u] - \alpha$

$$\mathbb{E}_{\theta_0, \lambda} [f(u(x))] = \mathbb{E}_{\theta_0, \lambda} [\phi(x)] - \alpha = 0 \quad \forall \lambda$$

$$\Rightarrow f(u) \stackrel{a.s.}{=} 0$$

$$\Rightarrow \mathbb{E}_{\theta_0} [\phi(x) | u(x) = u] = \alpha \quad \forall u$$

Two-sided case:

$$\begin{aligned} g(u) &= \frac{d}{d\theta} \mathbb{E}_{\theta_0} [\phi | u = u] \\ &= \mathbb{E}_{\theta_0} [(T - \mathbb{E}_{\theta_0} [T | u]) \phi | u] \\ &= \mathbb{E}_{\theta_0} [T(\phi - \alpha) | u] \end{aligned}$$

$$\mathbb{E}_{\theta_0, \lambda} g(u) = \mathbb{E}_{\theta_0, \lambda} [T(\phi - \alpha)] = \frac{\partial}{\partial \theta} B_{\phi}(\theta_0) = 0 \quad \forall \lambda$$

$$\Rightarrow \frac{d}{d\theta} \mathbb{E}_{\theta_0} [\phi | u] \stackrel{a.s.}{=} 0 \quad (\text{Cond'l power has derivative } 0 \text{ at } \theta_0)$$



Step 3: For any value  $u$ , the conditional model is  
 $q_{\theta}(t|u) = e^{\theta t - B_u(\theta)} g(t, u)$ , 1-param. exp. fam

In one- / two-sided case, we have shown  
 $\psi(t; u)$  is UMP / UMPU in  $\mathcal{Q}_u$

Let  $\bar{\phi}(t; u) = \mathbb{E}[\phi(x) | T(x)=t, u(x)=u]$

$$\begin{aligned}\mathbb{E}_{\theta_0}[\bar{\phi}(T; u) | u=u] &= \mathbb{E}_{\theta_0}[\phi(x) | u(x)=u] \\ &= \alpha \text{ if } \theta = \theta_0\end{aligned}$$

$\Rightarrow \bar{\phi}(\cdot; u)$  is a (cond'l) test of  $H_0$  vs.  $H_1$   
in  $\mathcal{Q}_u$  with power =  $\alpha$  at boundary

One-sided case: (or  $\theta \leq \theta_0$ )  
 $\psi(t; u)$  is the UMP test of  $\theta = \theta_0$  vs  $\theta > \theta_0$   
in  $\mathcal{Q}_u$ , which is a 1-param. exp. fam.

Two-sided case:

$\psi(t; u)$  is the UMP test of  $\theta = \theta_0$  vs.  $\theta \neq \theta_0$   
among tests with power =  $\alpha$ ,  $\frac{d}{d\theta}$  power = 0 @  $\theta_0$   
(Keener Thm 12.22, main thm. for two-sided tests)

In either case  $\psi$  has higher cond. power  
than  $\bar{\phi}$ , a.s.

For  $(\theta, \lambda) \in \Omega_1$ :

$$\begin{aligned}\mathbb{E}_{\theta, \lambda}[\phi(x)] &= \mathbb{E}_{\theta, \lambda} \left[ \mathbb{E}_{\theta} [\bar{\phi}(\tau; u) \mid u] \right] \\ &\leq \mathbb{E}_{\theta, \lambda} \left[ \mathbb{E}_{\theta} [\psi(\tau; u) \mid u] \right] \\ &= \mathbb{E}_{\theta, \lambda}[\phi^*(x)]\end{aligned}$$

$E_X$   $X_1, \dots, X_n \stackrel{iid}{\sim} N(\mu, \sigma^2)$   $\sigma^2 > 0$  unknown

$H_0: \mu = 0$  vs.  $H_1: \mu \neq 0$

$$p_{\mu, \sigma^2}(x) = e^{\underbrace{\frac{\mu}{\sigma^2}}_0 \underbrace{\sum X_i}_{T=\bar{x}} - \underbrace{\frac{1}{2\sigma^2}}_{\lambda} \underbrace{\sum X_i^2}_{u = \|x\|^2} - \frac{n\mu}{2\sigma^2}} \cdot \left(\frac{1}{2\pi\sigma^2}\right)^{n/2}$$

Optimal test rejects when  $\bar{X}$  is extreme given  $\|X\|$

If  $\mu = 0$ ,  $p$  is rotationally symmetric

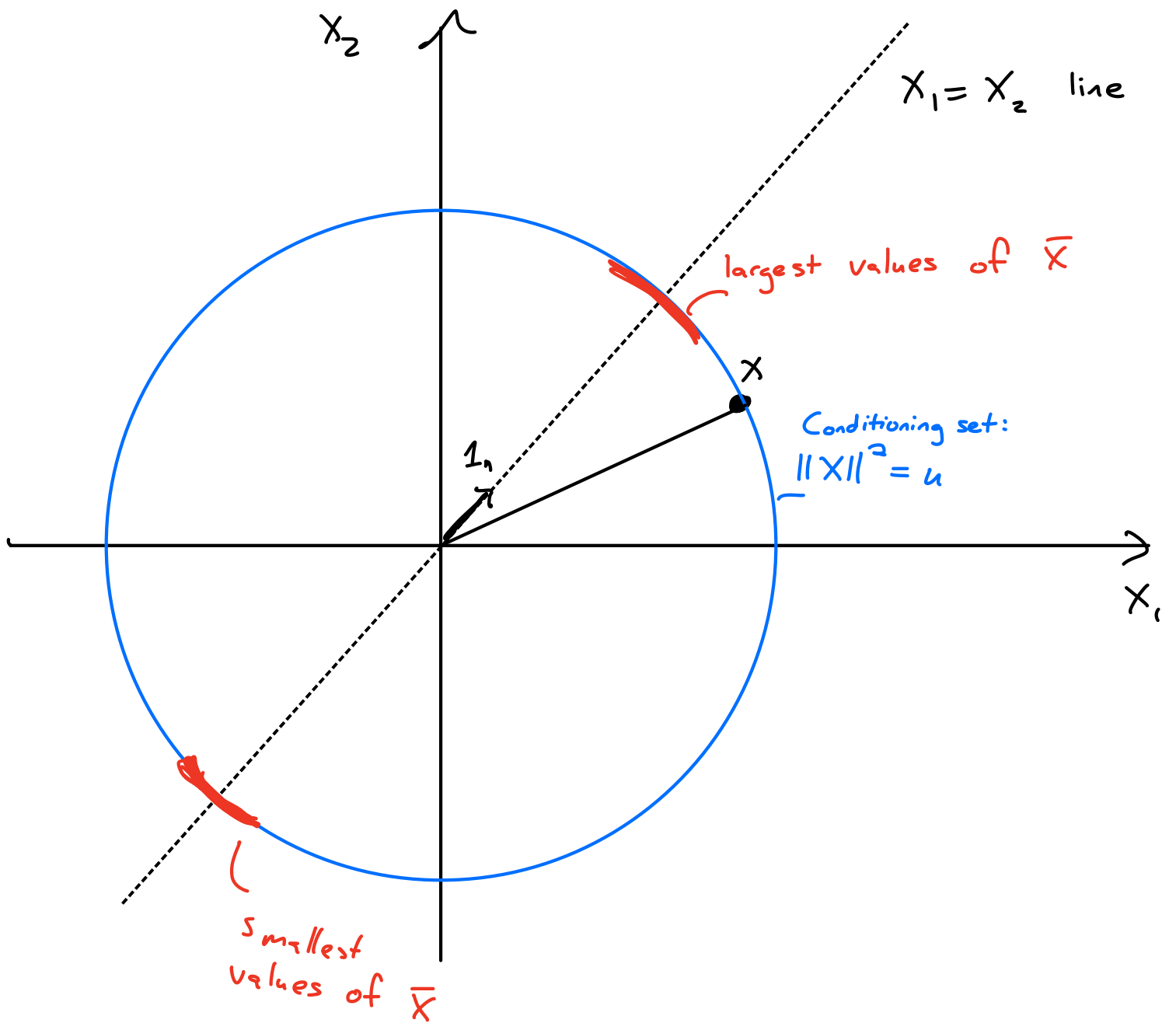
$$\Rightarrow X / \|X\|^2 \stackrel{H_0}{\sim} \text{Unif}(\sqrt{n} \cdot S^{n-1})$$

$$\left( \Leftrightarrow \frac{X}{\|X\|} \stackrel{H_0}{\sim} \text{Unif}(S^{n-1}), \text{ indep. of } \|X\| \right)$$

Optimal test rejects when  $\frac{\bar{X}}{\|X\|}$  extreme (marginally)

Could stop here & simulate

# Geometric Picture ( $n=2$ )



## t - statistic

Above test rejects for

- conditionally extreme  $\bar{X}$  given  $\|X\|^2$
- OR (equiv.) • marginally extreme  $\frac{\bar{X}}{\|X\|}$  ( $\perp \perp \|X\|^2$ )

Equivalent: reject for marginally extreme

$$T = \frac{\sqrt{n} \bar{X}}{\sqrt{S^2}}, \text{ where}$$

$$S^2 = \frac{1}{n-1} \sum (X_i - \bar{X})^2 \quad (\text{sample variance})$$

$$= \frac{1}{n-1} (\sum X_i^2 - 2\bar{X} \sum X_i + n\bar{X}^2)$$

$$= \frac{1}{n-1} (\|X\|^2 - n\bar{X}^2)$$

$$r \rightarrow \frac{r}{\sqrt{1-r^2}} : \text{---}$$

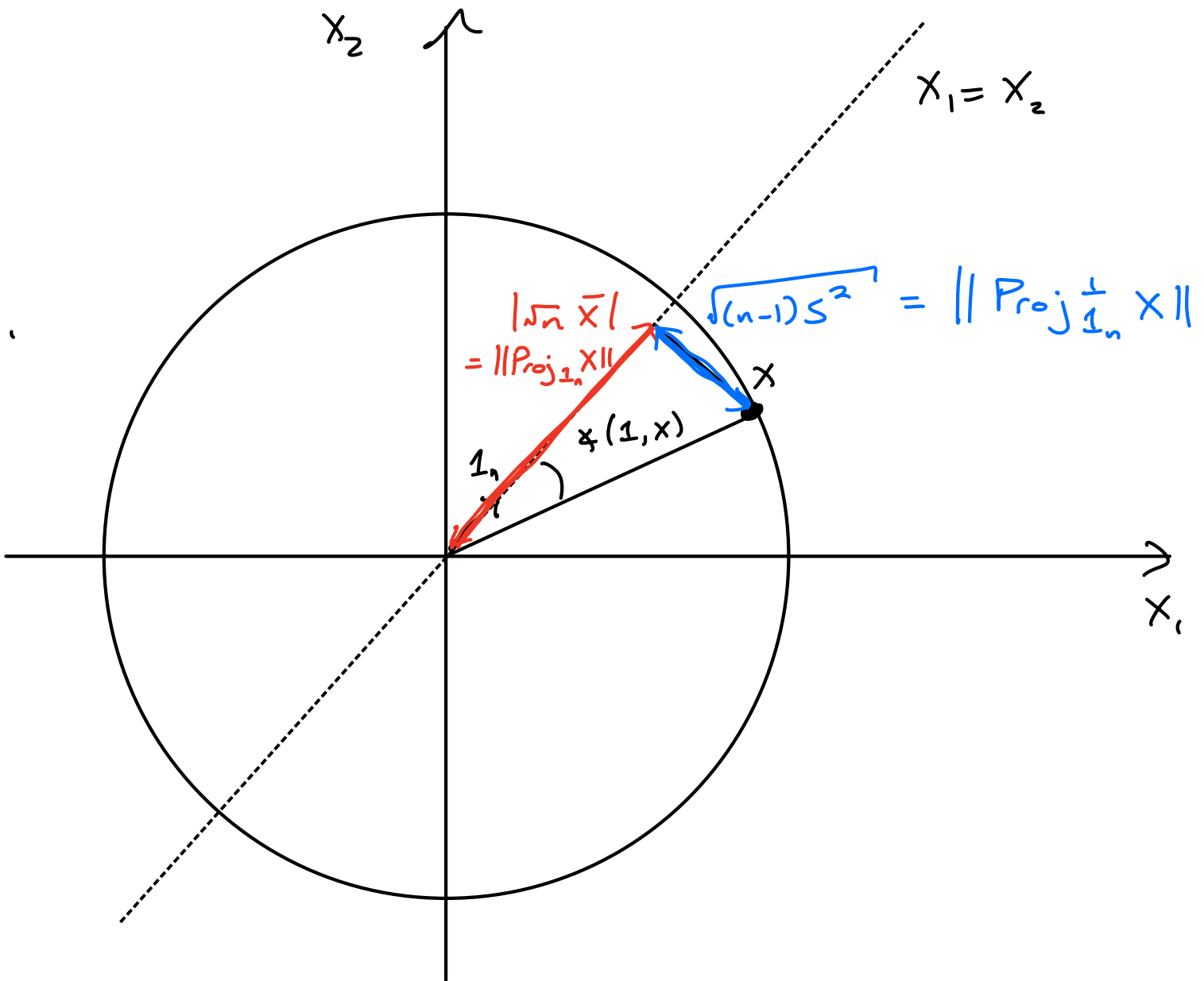
$$\Rightarrow T = \sqrt{n-1} \cdot \frac{\sqrt{n} \bar{X}}{\sqrt{\|X\|^2 - n\bar{X}^2}} = \sqrt{n-1} \cdot \frac{R}{\sqrt{1-R^2}}$$

$$\text{for } R = \frac{\sqrt{n} \bar{X}}{\|X\|} = \frac{\frac{1}{\sqrt{n}} \mathbf{1}_n \cdot X}{\|X\|} = \cos \angle(\mathbf{1}_n, X)$$

$$f\left(\frac{X}{\|X\|}\right) \Rightarrow \perp \perp \|X\|$$

# Geometric Picture

$$T = \frac{\sqrt{n} \bar{X}}{\sqrt{S^2}} = \frac{\| \text{Proj}_{1_n} X \|}{\| \text{Proj}_{1_n^\perp} X \|} \cdot \sqrt{n-1} \text{sgn}(\bar{X})$$



Next major theme: ratios of projections

## Permutation Tests

Even if we don't get a UMPU test at the end, conditioning on null suff. stat. still helps.

Ex.  $X_1, \dots, X_n \stackrel{iid}{\sim} P$   $Y_1, \dots, Y_m \stackrel{iid}{\sim} Q$   $H_0: P=Q$   $H_1: P \neq Q$

Under  $H_0$ ,  $P=Q$ ,  $X_1, \dots, X_n, Y_1, \dots, Y_m \stackrel{iid}{\sim} P$

Let  $(Z_1, \dots, Z_{n+m}) = (X_1, \dots, X_n, Y_1, \dots, Y_m)$

Under  $H_0$ ,  $U(Z) = (Z_{(1)}, \dots, Z_{(n+m)})$  compl. suff.

Let  $S_{n+m} = \{\text{Permutations on } n+m \text{ elements}\}$

$(X, Y) | U \stackrel{H_0}{\sim} \text{Unif}(\{\pi U : \pi \in S_{n+m}\})$

Thus, for any test stat  $T$ , if  $P=Q$ ,

$$P_{P,Q}(T(Z) \geq t | U) = \frac{1}{(n+m)!} \sum_{\pi \in S_{n+m}} \mathbb{1}\{T(\pi Z) \geq t\}$$

Monte Carlo test: In practice, we sample

$$\pi_1, \dots, \pi_B \stackrel{iid}{\sim} S_{n+m}, \quad \text{e.g. } B = 1000$$

Then  $Z, \pi_1 Z, \dots, \pi_B Z \stackrel{iid}{\sim} \text{Unif}(S_{n+m} U)$  under  $H_0$

$$\text{MC } p\text{-value } p = \frac{1}{1+B} \sum_{b=1}^B \mathbb{1}\{T(Z) \leq T(\pi_b Z)\}$$

$\stackrel{H_0}{\sim} \text{Unif}(\{\frac{1}{1+B}, \dots, \frac{B-1}{1+B}, 1\})$  (if no ties)

( $p \geq \text{Unif}(\cdot)$  if there are ties)